

*Silicon N-Channel Power MOSFET*

**General Description:**

The 2302 uses advanced trench technology and design to provide excellent RDS(ON) with low gate charge. It can be used in a wide variety of applications. The package form is SOT-23, which accords with the RoHS standard.

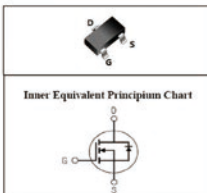
**Features:**

- Fast Switching
- Low Gate Charge and RdsOn
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

**Applications:**

PWM applications  
Load switch  
Power management

V <sub>OSS</sub>	20	V
I <sub>D</sub>	4.0	A
P <sub>D</sub>	1.0	W
R <sub>DS(ON)type</sub>	30	mΩ



**Absolute** (T<sub>c</sub> = 25 °C unless otherwise specified):

Symbol	Parameter	Rating	Units
V <sub>OSS</sub>	Drain-to-Source Voltage	30	V
I <sub>D</sub>	Continuous Drain Current	4.0	A
	Continuous Drain Current T <sub>c</sub> = 70 °C	3.2	A
I <sub>DM</sub> <sup>a1</sup>	Pulsed Drain Current	10	A
V <sub>GS</sub>	Gate-to-Source Voltage	±12	V
dv/dt <sup>a3</sup>	Peak Diode Recovery dv/dt	5.0	V/ns
P <sub>D</sub>	Power Dissipation	1.0	W
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range	150, -55 to 150	°C
T <sub>l</sub>	Maximum Temperature for Soldering	300	°C

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**Electrical Characteristics** (T<sub>c</sub>= 25°C unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V <sub>DSS</sub>	Drain to Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA	20	--	--	V
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	Bvdss Temperature Coefficient	ID=-250μA, Reference 25°C	--	0.1	--	V/°C
I <sub>DSS</sub>	Drain to Source Leakage Current	V <sub>DS</sub> = 20, V <sub>GS</sub> = 0V, T <sub>J</sub> = 25°C	--	--	1	μA
		V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C	--	--	250	
I <sub>DSS(F)</sub>	Gate to Source Forward Leakage	V <sub>GS</sub> = +20V	--	--	1	μA
I <sub>DSS(R)</sub>	Gate to Source Reverse Leakage	V <sub>GS</sub> = -20V	--	--	-1	μA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
R <sub>DS(ON)</sub>	Drain-to-Source On-Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =3.0A	--	30	45	mΩ
R <sub>DS(ON)</sub>	Drain-to-Source On-Resistance	V <sub>GS</sub> =2.5V, I <sub>D</sub> =3.0A	--	37	60	mΩ
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250μA	0.5	0.85	1.2	V
Pulse width tp ≤ 380μs, δ ≤ 2%						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =3.0A	8	--	--	S
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V V <sub>DS</sub> = 10V f = 1.0MHz	--	300	--	pF
C <sub>oss</sub>	Output Capacitance		--	120	--	
C <sub>rss</sub>	Reverse Transfer Capacitance		--	80	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
t <sub>d(ON)</sub>	Turn-on Delay Time	I <sub>D</sub> = 3.0A V <sub>DS</sub> = 10V V <sub>GS</sub> = 10V R <sub>G</sub> = 6.0Ω	--	10	--	ns
t <sub>r</sub>	Rise Time		--	50	--	
t <sub>d(OFF)</sub>	Turn-Off Delay Time		--	17	--	
t <sub>f</sub>	Fall Time		--	10	--	
Q <sub>g</sub>	Total Gate Charge		--	4.0	--	
Q <sub>gs</sub>	Gate to Source Charge	I <sub>D</sub> = 3.0A V <sub>DS</sub> = 10V V <sub>GS</sub> = 4.5V	--	0.7	--	nC
Q <sub>gd</sub>	Gate to Drain ("Miller") Charge	--	1.5	--		

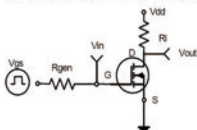
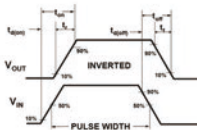
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Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$I_S$	Continuous Source Current (Body Diode)		--	--	4.0	A
$I_{SM}$	Maximum Pulsed Current (Body Diode)		--	--	10.0	A
$V_{SD}$	Diode Forward Voltage	$I_S=4.0A, V_{GS}=0V$	--	--	1.5	V
$t_{rr}$	Reverse Recovery Time	$I_S=4.0A, T_J=25^\circ C$	--	25	--	ns
$Q_{rr}$	Reverse Recovery Charge	$di/dt=100A/\mu s, V_{GS}=0V$	--	60	--	nC
Pulse width $t_p \leq 380\mu s, \delta \leq 2\%$						

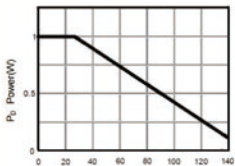
Symbol	Parameter	Typ.	Units
$R_{JA}$	Junction-to-Ambient	125	$^\circ C/W$

<sup>\*1</sup>: Repetitive rating; pulse width limited by maximum junction temperature

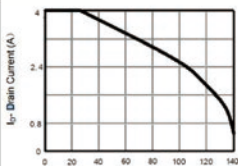
<sup>\*2</sup>:  $I_{SD}=4.0A, di/dt \leq 100A/\mu s, V_{SD} \leq BV_{DS}, \text{Start } T_J=25^\circ C$

**Typical Electrical and Thermal Characteristics**

**Figure 1: Switching Test Circuit**

**Figure 2: Switching Waveforms**

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$T_J$  Junction Temperature (°C)  
Figure 3 Power Dissipation



$T_J$  Junction Temperature (°C)  
Figure 4 Drain Current

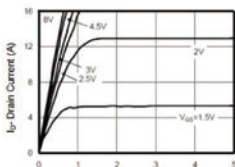


Figure 5 Output Characteristics

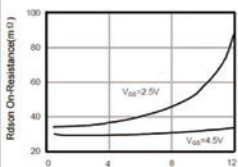


Figure 6 Drain-Source On-Resistance

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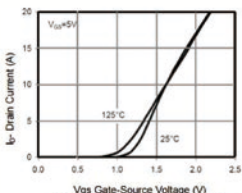


Figure 7 Transfer Characteristics

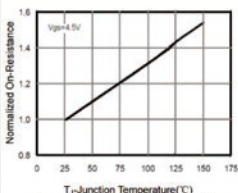


Figure 8 Drain-Source On-Resistance

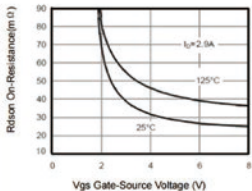


Figure 9 Rds(on) vs Vgs

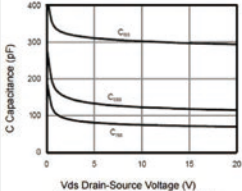


Figure 10 Capacitance vs Vds

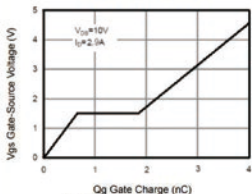


Figure 11 Gate Charge

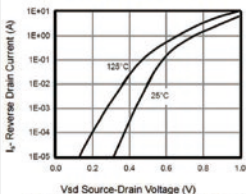
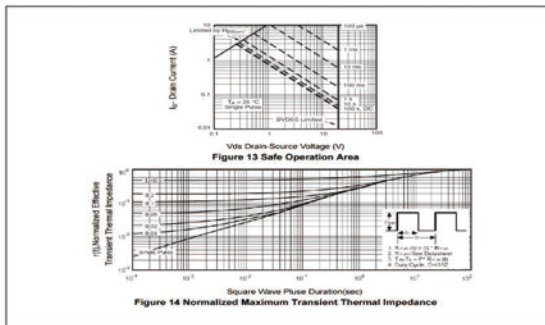


Figure 12 Source-Drain Diode Forward

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